

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10540501	HAMEAU ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chen, Shin-Hon	2131

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
713	190,193,194,300, 322	1/4/08	S.C.

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	1/4/08	S.C.
NPL search (google)	1/4/08	S.C.

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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